# Phase Diagrams of the Ternary Systems Mn, Fe, Co, Ni–Si–N\*

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Received December 20, 1986

Phase equilibria in the ternary systems Mn, Fe, Co, and Ni–Si–N are investigated and isothermal sections at 900°C (Fe–Si–N, Ni–Si–N), at 1000°C (Mn–Si–N, Co–Si–N) and at 1150°C (Fe–Si–N) are presented. In the system Mn–Si–N, Si<sub>3</sub>N<sub>4</sub> coexists with MnSiN<sub>2</sub>, Mn<sub>3</sub>Si, Mn<sub>5</sub>Si<sub>3</sub>, MnSi, and MnSi<sub>2-x</sub>. In the systems Fe, Co, Ni–Si–N, Si<sub>3</sub>N<sub>4</sub> coexists with all binary silicides but reacts rapidly with iron above 1120  $\pm$  10°C, and cobalt and nickel above 1170  $\pm$  10°C to form binary silicides and nitrogen gas. © 1987 Academic Press, Inc.

## Introduction

Silicon nitride is one of the most attractive advanced ceramic materials of today. Although much is known regarding wetting, metallizing, and joining  $Si_3N_4$  to base metals no rationale of these data in the form of phase diagrams is available. This prompted a systematic investigation of such transition metal-silicon-nitrogen systems and the first set of ternary phase diagrams is presented here.

### **Literature Review**

Liquid manganese wets silicon nitride ( $\vartheta$  = 74°) (1) and is reported to react violently with Si<sub>3</sub>N<sub>4</sub> at 1270°C under vacuum as well as in inert gas (2). The compounds identified as the reaction products are MnSiN<sub>2</sub>, Mn<sub>3</sub>Si, and Si<sub>3</sub>N<sub>4</sub> (800°C, argon) and Mn<sub>5</sub>Si<sub>3</sub> and Si<sub>3</sub>N<sub>4</sub> (1200°C, argon), respectively (3). The ternary phase MnSiN<sub>2</sub> is orthorhombic, space group  $Pna2_1$ , a = 0.5258 nm, b = 0.6511 nm, and c = 0.5070 nm (4). MnSiN<sub>2</sub> was found to form as well by reaction of manganese with silicon under nitrogen (3). The decomposition of MnSiN<sub>2</sub> into MnSi and N<sub>2</sub> gas starts under nitrogen (10<sup>5</sup> Pa) above 1300°C and under argon above 800°C (3).

Silicon nitride is reported to decompose in contact with iron at temperatures above  $700^{\circ}C$  (5). This reaction is described to be fast and violent at higher temperatures, especially above the melting point of iron (1, 2, 6). At 1200°C, Si<sub>3</sub>N<sub>4</sub> whiskers are observed to be dissolved in an Fe matrix (7). The reaction products found are binary iron silicides and nitrogen gas. A temperature of 1300°C is reported to be necessary to decompose the silicon nitride completely in an alloy Fe + 6 wt%  $Si_3N_4$  in order to obtain an nitride-free alloy (8). The same author observed that at 1150°C the nitrogen evolution is reduced under vacuum compared to a hydrogen atmosphere. Tennenhouse et al. (9) investigated the interaction

<sup>\*</sup> Dedicated to Dr. H. Nowotny.

of Si<sub>3</sub>N<sub>4</sub> cutting tools with iron and ironbased alloys in air. They conclude that the low melting phase formed during machining is an oxide phase and does not occur in the ternary Fe-Si-N. Joining Si<sub>3</sub>N<sub>4</sub> to steel by hot pressing resulted in excellent bonding due to the formation of Fe-silicides in the interlayer. However, due to thermal expansion mismatching, low tensile strength (failure in the  $Si_3N_4$ ) resulted (10). Iron is often used as an addition in silicon to aid nitridation. The reaction products found are  $Si_3N_4$  and iron silicides (11, 12), which, however, are recognized to be the primary course of strength degradation in hot pressed silicon nitride (13). These results are in agreement with the observation that no bonding takes place and Si<sub>3</sub>N<sub>4</sub> is apparently compatible with FeSi (at 1500°C, vacuum, wetting angle  $\vartheta = 76^{\circ}$ ) and Fe<sub>2</sub>Si<sub>5</sub> (at 1450°C, vacuum, wetting angle  $\vartheta = 66^{\circ}$ ) (14). On the other hand nitriding FeSi<sub>2</sub> leads to the formation of  $Si_3N_4$  + Fe at 1200°C according to Matsumoto et al. (15).

Liquid cobalt is reported to decompose  $Si_3N_4$  (1, 6) by the formation of binary silicides and nitrogen gas. The binary silicides CoSi and "Co<sub>3</sub>Si" were found to be compatible with  $Si_3N_4$  (14). No bonding to the ceramic was observed. The wetting angles are  $\vartheta = 62^\circ$  and  $\vartheta < 40^\circ$ , respectively. Silicon nitride acts as diffusion barrier between Co and Si in shallow-junction VLSI devices (16).

Liquid nickel is also reported to decompose Si<sub>3</sub>N<sub>4</sub> (1, 2, 6) under the formation of binary silicides and nitrogen gas. This reaction was observed to already take place at temperatures above 1000°C (17). These observations are in accord with reports on the degradation of Si<sub>3</sub>N<sub>4</sub> whiskers in a nickel matrix in the temperature range between 1000 and 1200°C (7, 18–20). The apparent compatibility of Si<sub>3</sub>N<sub>4</sub> with Ni<sub>2</sub>Si was concluded from the wetting angle of Ni<sub>2</sub>Si on Si<sub>3</sub>N<sub>4</sub> ( $\vartheta = 108^\circ$ , no wetting) (14). Nitriding silicon with the addition of Ni results in the formation of nickel silicides besides  $Si_3N_4$  (11).

Phase diagram data of the binary siliconmetal and nitrogen-metal systems are taken from literature references: Mn-Si from Moffatt (21); Fe-Si from Schürmann and Hensgen (22); Co-Si from Hansen (23) updated by the work of van den Boomgaard and Carpay (24) as well as Köster *et al.* (25); Ni-Si from Osawa and Okamoto (26), Oya and Suzuki (27), and Ellner *et al.* (28); Mn-N from Zwicker (29), Lihl *et al.* (30), and Kudielka and Grabke (31); Fe-N from Kubaschewski von Goldbeck (32).

No phase diagrams are reported for Co-N and Ni-N. Crystal structure data of the intermediate phases are compiled by Villars and Calvert (33).

#### **Experimental Procedures**

In order to identify all binary silicide phases and to obtain master alloys for further preparation, binary metal-silicon alloys were prepared by arc melting under argon (99.999% pure) from powders or ingots of the constituting elements using the starting materials listed below.<sup>1</sup> Ternary compositions were prepared by mixing powders of these master alloys and binary nitride powders. These ternary mixtures were cold pressed and sintered in evacuated quartz tubes lined with Mo or Ta foil.

X-ray diffraction (Co $K\alpha_1$  radiation, Cr $K\alpha$  radiation) was performed on all alloys using

<sup>&</sup>lt;sup>1</sup> Silicon powder, purity m99.9%, from Alpha Div., Ventron Corp., USA; silicon lump, purity m99.9999%, from Alpha Div., Ventron Corp., USA; iron powder, purity 99.5%, impurities (in ppm): Ni 600, C < 600, O < 2000, from Fluka AG, Switzerland; cobalt powder, purity 99.8%, impurities (in ppm): Cu < 50, Pb < 50, Fe < 500, Zn < 50, Ni < 500, Mn < 50; from Fluka AG, Switzerland; nickel powder, purity m99.9%, from Alpha Div., Ventron Corp., USA; silicon nitride (mixture of α-Si<sub>3</sub>N<sub>4</sub> and β-Si<sub>3</sub>N<sub>4</sub>), powder 58% Si; from Alpha Div., Ventron Corp., USA; manganese nitride (Mn<sub>2</sub>N) powder, purity 99.9%, from Alpha Div., Ventron Corp.

Guinier or Debye–Scherrer cameras. In several ternary systems silicon nitride coexists with the transition metal at 1000°C. In order to determine the temperature at which reaction takes place, a large pellet (5-10 g) of the cold compacted powder mixture  $(Si_3N_4 + 30 \text{ at.}\% Me)$  was placed in an RF furnace under vacuum and heated slowly. Monitoring with an optical pyrometer the increase in temperature versus the gas pressure (on a logarithmic scale with arbitrary units) permits direct observation of the onset of gas evolution resulting from the reaction

$$\mathrm{Si}_{3}\mathrm{N}_{4} + xMe \rightarrow Me_{x}\mathrm{Si}_{3} + 2\mathrm{N}_{2}\uparrow$$
.

Furthermore the nitrogen gas acts as transporting agents for metallic vapors which are deposited on the quartz window, therefore virtually bringing to an end the optical temperature measurements at the onset of the reaction.

### **Results and Discussion**

### The Ternary System Manganese– Silicon–Nitrogen

All phases and crystal structures reported for the binary system Mn-Si (21, 33) could be corroborated and are confirmed. Mn<sub>5</sub>Si<sub>2</sub>, found at 700°C, could not be observed at temperatures of 800°C and above. No other discrepancies with the established phase diagram are observed. The lattice parameters found are Mn<sub>6</sub>Si (Mn<sub>0.855</sub>Si<sub>0.195</sub>,  $\epsilon$ -phase), a = 1.08916 nm, c = 1.92056 nm;  $Mn_9Si_2$  ( $Mn_{0.815}Si_{0.185}$ ,  $\xi$ -phase), a = 1.70195nm, b = 2.86750 nm, c = 0.46675 nm;  $Mn_3Si a = 0.57242 nm; Mn_5Si_2 a = 0.89001$ nm, c = 0.87084 nm, Mn<sub>5</sub>Si<sub>3</sub> a = 0.68988nm, c = 0.48096 nm; MnSi a = 0.45593 nm; and  $Mn_{15}Si_{26} a = 0.55309 \text{ nm}, c = 6.54763$ nm. The lattice parameter of  $\beta$ -Mn(s.s) in an alloy  $Mn_{0.90}Si_{0.10}$  annealed at 800°C was a = 0.62869 nm.

In the ternary system the phase MnSiN<sub>2</sub>

was formed at 1000°C upon reaction of Si<sub>3</sub>N<sub>4</sub> with manganese. MnSiN<sub>2</sub> coexists in the absence of external nitrogen pressure with Si<sub>3</sub>N<sub>4</sub>, Mn<sub>3</sub>Si,  $\beta$ -Mn(s.s.), and nitrogen gas (Fig. 1). The lattice parameters found are a = 0.52656 nm, b = 0.65222 nm, c =0.50737 nm (Si-rich) and a = 0.52678 nm, b = 0.65208 nm, c = 0.50693 nm (Mn-rich). MnSiN<sub>2</sub> may therefore be considered a line compound having only a very narrow homogeneity range. A three-phase field  $(MnSiN_2 + Mn_3Si + \beta - Mn(s.s.))$  was observed. Hence the stability of Mn<sub>9</sub>Si<sub>2</sub>, which was found to exist in the binary Mn-Si system at this temperature, is confined to compositions close to the binary Mn-Si by a tieline between Mn<sub>3</sub>Si and  $\beta$ -Mn(s.s.). Si<sub>3</sub>N<sub>4</sub> coexists with MnSi<sub>2-x</sub>, MnSi, Mn<sub>5</sub>Si<sub>3</sub>, and Mn<sub>3</sub>Si besides MnSiN<sub>2</sub> (Table I). No solubility of nitrogen was observed in any of the manganese silicides. If the external nitrogen pressure is not negligible the formation of  $\gamma$ -Mn(s.s.) modifies the phase equilibria at the Mn-rich corner of the ternary system (Fig. 2). With further increase of the external nitrogen partial pressure, manganese nitrides richer in nitrogen coexist with MnSiN<sub>2</sub>. Thus



FIG. 1. Isothermal section of the ternary system Mn-Si-N at 1000°C (in the absence of external nitrogen pressure).

#### TABLE I

Solid-State Reaction Products Observed in the System Mn–Si–N upon Annealing at 1000°C, 120 h (Evacuated Quartz Tubes)

Mn <sub>0.366</sub> Si <sub>0.634</sub>	(am) -	- Si <sub>3</sub> N <sub>4</sub> (15 at.%	N) $\rightarrow$	$Si_3N_4 + MnSi_{2-x}$
Mn <sub>0.50</sub> Si <sub>0.50</sub>	(am) -	- Si <sub>3</sub> N₄ (15 at.%	N) $\rightarrow$	$Si_3N_4 + MnSi + Mn_5Si_3$
Mn <sub>0.625</sub> Si <sub>0.375</sub>	(am) -	+ Si <sub>3</sub> N₄ (15 at.%	N) $\rightarrow$	$Si_3N_4 + Mn_5Si_3$
Mn <sub>0.714</sub> Si <sub>0.286</sub>	(am) -	- Si <sub>3</sub> N <sub>4</sub> (15 at.%	N) $\rightarrow$	$Si_3N_4 + Mn_5Si_3 + Mn_3Si$
Mn <sub>0.75</sub> Si <sub>0.25</sub>	(am) -	- Si <sub>3</sub> N₄ (15 at.%	N) $\rightarrow$	$Si_3N_4 + Mn_3Si + MnSiN_2$
Mn <sub>0.75</sub> Si <sub>0.25</sub>	(am) -	5i3N4 (20 at.%	N) $\rightarrow$	$Si_3N_4 + Mn_3Si + MnSiN_2$
Mn <sub>0.818</sub> Si <sub>0.182</sub>	(am) -	+ Si <sub>3</sub> N <sub>4</sub> (20 at.%	N) $\rightarrow$	$Mn_3Si + MnSiN_2$
Mn <sub>0.85</sub> Si <sub>0.15</sub>	(am) -	+ Si <sub>3</sub> N <sub>4</sub> (15 at.%	N) $\rightarrow$	$Mn_3Si + MnSiN_2 + \beta - Mn(s.s.)$
Mn <sub>0.90</sub> Si <sub>0.10</sub>	(am) -	+ Si <sub>3</sub> N <sub>4</sub> (15 at.%	N) $\rightarrow$	$Mn_3Si + MnSiN_2 + \beta - Mn(s.s.)$

Note. am stands for arc-melted.

room temperature X-ray diffraction of alloys annealed at 1273 K under  $5 \times 10^4$  Pa nitrogen and quenched to liquid nitrogen temperature shows the formation of cubic  $\varepsilon$ -Mn<sub>4</sub>N. However, *in situ* high-temperature X-ray diffraction of a specimen having the same nominal composition indicates the existence of a hexagonal phase at 1273 K, confirming Kudielka and co-workers (31).

## The Ternary System Iron–Silicon– Nitrogen

All phases and crystal structures reported for the binary Fe-Si system (22, 23) are corroborated and confirmed. According to Kudielka (34) the high-temperature Fe<sub>2</sub>Si is hexagonal; however, phase quenching in water was claimed to be insufficient to retain the hexagonal symmetry and a primitive cubic pattern is obtained instead (35). The lattice parameters found are for Fe<sub>2</sub>Si<sub>5</sub>: a = 0.26879 nm, c = 0.51281nm; FeSi<sub>2</sub>: a = 0.98789 nm, b = 0.78038nm, c = 0.78408 nm; FeSi: a = 0.44844 nm;  $Fe_5Si_3$ : a = 0.67426 nm, c = 0.47146 nm;  $\alpha_2$ -Fe<sub>3</sub>Si: a = 0.28100 nm at the Si-rich phase boundary;  $\alpha_1$ -Fe<sub>3</sub>Si: a = 0.5650 nm (at 75 at.% Fe).

Two isothermal sections have been established in the ternary Fe–Si–N. At 900°C (Fig. 3)  $Si_3N_4$  was found to coexist with all binary silicides stable at this temperature and  $\alpha$ -Fe (Table II). At 1150°C (Fig. 4) Si<sub>3</sub>N<sub>4</sub> is decomposed by pure iron, forming  $\alpha$ -Fe containing 6-8 at.% Si in solid solution. The onset of this decomposition reaction was observed at 1120 ± 10°C. All other binary phases stable 1150°C were found to coexist with Si<sub>3</sub>N<sub>4</sub> (Table II). However, as mentioned in the previous section, the phase Fe<sub>2</sub>Si could not be observed, probably due to insufficient quenching. Specimens along the tieline Si<sub>3</sub>N<sub>4</sub> + Fe<sub>2</sub>Si showed the X-ray diffraction patterns of Si<sub>3</sub>N<sub>4</sub>, Fe<sub>5</sub>Si<sub>3</sub>, and Fe<sub>3</sub>Si. It was not possible



FIG. 2. Isothermal section of the ternary system Mn-Si-N at 1000°C (external nitrogen pressure not negligible).



FIG. 3. Isothermal section of the ternary system Fe-Si-N at 900°C (in the absence of external nitrogen pressure).



FIG. 4. Isothermal section of the ternary system Fe-Si-N at 1150°C (in the absence of external nitrogen pressure).

to distinguish between  $\alpha_1$ - and  $\alpha_2$ -Fe<sub>3</sub>Si due to coincidences of X-ray diffraction lines of Si<sub>3</sub>N<sub>4</sub> with the weak lines characteristic for the ordered  $\alpha_1$ -Fe<sub>3</sub>Si phase. However, the smaller lattice parameter of  $\alpha_2$ -Fe<sub>3</sub>Si (a = 0.282 nm) with respect to the  $\alpha_1$ -Fe<sub>3</sub>Si subcell ( $a = 2 \times a_0 = 2 \times 0.283$  nm) served as an indicator.

Solid-State Reaction Products in the System Fe–Si–N								
Upon annealing at 900°C for 340 h (evacuated quartz tube)								
$Fe_{0.33}Si_{0.67} + Si_3N_4$	(10 at.% N)		$FeSi_2 + Si_3N_4$					
$Fe_{0.50}Si_{0.50} + Si_3N_4$	(20 at.% N)	$\rightarrow$	FeSi + Si <sub>3</sub> N <sub>4</sub>					
Fe <sub>0.625</sub> Si <sub>0.375</sub> + Si <sub>3</sub> N <sub>4</sub>	(15 at.% N)	$\rightarrow$	$Fe_5Si_3 + Si_3N_4$					
$Fe_{0.67}Si_{0.33} + Si_3N_4$	(10 at.% N)	$\rightarrow$	$Fe_5Si_3 + \alpha_2 - Fe_3Si + Si_3N_4$					
$Fe_{0.75}Si_{0.25} + Si_3N_4$	(10 at.% N)	$\rightarrow$	$\alpha_1$ -Fe <sub>3</sub> Si + Si <sub>3</sub> N <sub>4</sub>					
$Fe + Si_3N_4$	(10 at.% N)	$\rightarrow$	$\alpha$ -Fe + Si <sub>3</sub> N <sub>4</sub>					
$Fe + Si_3N_4$	(20 at.% N)	$\rightarrow$	$\alpha$ -Fe + Si <sub>3</sub> N <sub>4</sub>					

TABLE II

Upon annealing at 1150°C for 170 h (evacuated quartz tube)

 $Fe_{0.285}Si_{0.715} + Si_3N_4$  (10 at.% N)  $Fe_2Si_5 + FeSi + Si_3N_4$  $Fe_{0.33}Si_{0.67} + Si_3N_4$  (10 at.% N)  $Fe_2Si_5 + FeSi + Si_3N_4$  $Fe_{0.50}Si_{0.50} + Si_3N_4$  (20 at.% N)  $FeSi + Si_3N_4$  $Fe_{0.625}Si_{0.375} + Si_3N_4$  (10 at.% N)  $Fe_5Si_3 + \alpha_2 - Fe_3Si(a = 0.2834 \text{ nm})$ + Si<sub>3</sub>N<sub>4</sub> (insufficient quench)  $Fe_{0.67}Si_{0.33} + Si_3N_4$  (10 at.% N)  $\alpha_2$ -Fe<sub>3</sub>Si (a = 0.2823 nm) + Si<sub>3</sub>N<sub>4</sub>  $\rightarrow$ Upon annealing at 1150°C for 60 h (RF-furnace, 10<sup>5</sup> Pa argon)  $Fe_{0.75}Si_{0.25} + Si_3N_4$  (15 at.% N)  $\alpha_1$ -Fe<sub>3</sub>Si(a = 0.56549 nm) + Si<sub>3</sub>N<sub>4</sub>  $\rightarrow$  $Fe_{0.90}Si_{0.10} + Si_3N_4$  (15 at.% N) α-Fe  $(a = 0.28601 \text{ nm}) + \text{Si}_3 N_4$ 

#### TABLE III

Solid-State Reaction Products Observed in the System Co-Si-N upon Annealing at 1000°C, 170 h (Evacuated Quartz Tubes)

$Co_{0.33}Si_{0.67} + Si_3N_4$ (20 at.% N)	<b>→</b>	$CoSi_2 + Si_3N_4$
$Co_{0.50}Si_{0.50} + Si_3N_4$ (10 at.% N)	$\rightarrow$	CoSi + Si <sub>3</sub> N <sub>4</sub>
$Co_{0.625}Si_{0.375} + Si_3N_4$ (10 at.% N)	$\rightarrow$	$CoSi + L.TCo_2Si + Si_3N_4$
$Co_{0.67}Si_{0.33} + Si_3N_4$ (10 at.% N)	$\rightarrow$	L.TCo2Si + Si3N4
$Co + Si_3N_4$ (10 at.% N)	<b>→</b>	$Co(\alpha + \varepsilon) + Si_3N_4$

# The Ternary System Cobalt– Silicon–Nitrogen

The three intermediate phases reported to exist at 1000°C in the Co-Si system (23-25, 33) are corroborated and confirmed. The lattice parameters found are for CoSi<sub>2</sub>: a = 0.53526 nm; CoSi: a = 0.44449nm; L.T.-Co<sub>2</sub>Si: a = 0.49073 nm, b =0.37333 nm, c = 0.70963 nm. The hightemperature phases H.T.-Co<sub>2</sub>Si and Co<sub>3</sub>Si were not observed under the experimental conditions chosen.

At 1000°C Si<sub>3</sub>N<sub>4</sub> coexists with cobalt and all binary cobalt silicides stable at this temperature (Table III). The onset of a reaction between Si<sub>3</sub>N<sub>4</sub> and Co is found to be at 1170°C from log p versus temperature data. No ternary phase is observed. No solubility of nitrogen in the binary silicides is detected. An isothermal section at 1000°C is shown in Fig. 5.

## The Ternary System Nickel– Silicon–Nitrogen

All the phases and crystal structures reported for the binary system Ni–Si (26-28, 33) are corroborated and confirmed with the exception of the high-temperature modifications of NiSi<sub>2</sub>, Ni<sub>2</sub>Si, and Ni<sub>3</sub>Si. Attempts to obtain H.T.-Ni<sub>2</sub>Si by quenching an alloy from 940 and 1020°C, respectively, into liquid nitrogen did not result in the formation of the desired phase. No specific effort was made to obtain H.T.-NiSi<sub>2</sub> or H.T.-Ni<sub>3</sub>Si. The lattice parameters of the silicides found are for L.T.-NiSi<sub>2</sub>: *a* 



FIG. 5. Isothermal section of the ternary system Co-Si-N at 1000°C (in the absence of external nitrogen pressure).

= 0.54030 nm; NiSi: a = 0.51810 nm, b = 0.33365 nm, c = 0.56140 nm; Ni<sub>3</sub>Si<sub>2</sub>: a = 1.22363 nm, b = 1.08135 nm, c = 0.69213 nm; L.T.-Ni<sub>2</sub>Si: a = 0.50040 nm, b = 0.37333 nm, c = 0.70715 nm; Ni<sub>31</sub>Si<sub>12</sub>: a = 0.66777 nm, c = 1.2280 nm; Ni<sub>25</sub>Si<sub>9</sub>: a = 0.67022 nm, c = 2.88954 nm; L.T.-Ni<sub>3</sub>Si: a = 0.35098 nm.

In the ternary system Ni–Si–N Si<sub>3</sub>N<sub>4</sub> coexists at 900°C with nickel and all binary nickel silicides stable at this temperature (Table IV). Decomposition of Si<sub>3</sub>N<sub>4</sub> by Ni is very fast above 1170°C, but below this temperature Ni and Si<sub>3</sub>N<sub>4</sub> seem to coexist. No ternary phase is observed. No solubility of nitrogen in the binary silicides is de-

#### TABLE IV

Solid State Reaction Products in the System Ni–Si–N upon Annealing at 900°C up to 340 h (Evacuated Quartz Tubes)

$Ni_{0.33}Si_{0.67} + Si_3N_4$ (10 at.% N)	$\rightarrow$	L.TNiSi <sub>2</sub> + NiSi + Si <sub>3</sub> N <sub>4</sub>
$Ni_{0.50}Si_{0.50} + Si_3N_4$ (10 at.% N)	$\rightarrow$	NiSi + Si <sub>3</sub> N <sub>4</sub>
$Ni_{0.60}Si_{0.40} + Si_3N_4$ (10 at.% N)	$\rightarrow$	$Ni_3Si_2 + L.TNi_2Si + Si_3N_4$
$Ni_{0.67}Si_{0.33} + Si_3N_4$ (15 at.% N)	$\rightarrow$	$L.TNi_2Si + Si_3N_4$
$Ni_{0.715}Si_{0.285} + Si_3N_4$ (15 at.% N)	$\rightarrow$	L.TNi2Si + Si3N4
$Ni_{0.75}Si_{0.25} + Si_3N_4$ (18 at.% N)	$\rightarrow$	L.TNi3Si + Si3N4
Ni + Si <sub>3</sub> N <sub>4</sub> (10 at.% N)	$\rightarrow$	Ni + Si <sub>3</sub> N <sub>4</sub>



FIG. 6. Isothermal section of the ternary system Ni–Si–N at 900°C (in the absence of external nitrogen pressure).

tected. The isothermal section at 900°C is shown in Fig. 6.

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